


<b>Search Notes</b>  	<b>Application/Control No.</b>  10814547	<b>Applicant(s)/Patent Under Reexamination</b>  HAILEY ET AL.
	<b>Examiner</b>  Faber, David	<b>Art Unit</b>  2178

SEARCHED			
Class	Subclass	Date	Examiner
715	201-204, 234-242, 209	12/17/2008	/DF/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (Search Notes Attached)	12/17/2008	/DF/
Discussed with SPE William Bashore, and Primary Examiner Cesar Paula	12/17/2008	/DF/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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